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|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 09/981,688 | | Applicant(s)/Patent Under Reexamination TANSKANEN ET AL. | |
| | Examiner X. L. Bautista | | Art Unit 2179 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,222,520 B1 | 04-2001 | Gerszberg et al. | 715/784 |
| * | B | US-5,796,967 | 08-1998 | Filepp et al. | 715/764 |
| * | C | US-6,449,601 B1 | 09-2002 | Friedland et al. | 705/37 |
| * | D | US-2004/0024610 A1 | 02-2004 | Fradkov et al. | 705/1 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------------------------|----------------|
| | N | EP 000552822 A2 | 07-1993 | EPO | Yves AUDEBERT et al | G06F 1/00 |
| | O | JP 408194753 A | 07-1996 | JPO | Wataru YOSHIHARA et al | G06F 19/00 |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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